

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

TRANSLATION CERTIFICATE

(not for PCT cases)

In re PATENT APPLICATION of
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Attention:

Appln. No. _____

Application Division:

Filed: September 26, 2003

Title: Objective

VERIFIED TRANSLATION
UNDER RULE 52(d)
FOR APPLICATION ALREADY FILED

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Signed this 10th day of March, 2004.

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OBJECTIVE

BACKGROUND OF THE INVENTION

1. Field of the Invention

This invention relates to a microscope objective, and in particular, to a high-NA, high-magnification, and infinity-correction type objective used in a deep ultraviolet region corresponding to a wavelength of approximately 250 nm.

2. Description of Related Art

It is known that objectives used in a deep ultraviolet (DUV) region corresponding to a wavelength of approximately 250 nm are roughly divided into three types. The first type objective is constructed with only a plurality of lenses made with the same medium (quartz, mostly), and is designed so that chromatic aberration cannot be corrected in theory (refer to, for example, Japanese Patent Kokai Nos. Hei 6-242381 and Hei 10-104510). The second type objective is constructed so that lenses made with different media (quartz and fluorite, mostly) are cemented together with an adhesive and chromatic aberration can be corrected (refer to, for example, Japanese Patent Kokai Nos. Hei 5-72482, Hei 9-243923, Hei 11-249025, and 2001-42224). The third type objective is designed so that, of a plurality of lenses, a lens made of quartz and a lens of fluorite are used to correct chromatic aberration, but so that both lenses are not cemented with the adhesive (refer to, for example, Japanese Patent Kokai Nos. Hei 11-167067 and 2001-318317).

The resolution of a microscope is fundamentally determined by a wavelength and the numerical aperture of the objective. The median wavelength of visible light used in an ordinary microscope is approximately 550 nm and the maximum numerical aperture of a dry objective is about 0.9. Therefore, when a wavelength to be used is set to around 250 nm, the resolution is roughly doubled because the wavelength is halved. However, this is limited to the case where the numerical aperture

remains unchanged. With a wavelength of about 0.4, even though the wavelength to be used is set to around 250 nm, both the wavelength and the numerical aperture are halved, and thus the resolution is counteracted and is exactly the same as in a conventional microscope.

SUMMARY OF THE INVENTION

The objective according to the present invention has lens units, each of which is constructed with single lenses, and a numerical aperture of 0.7 or more, comprising, in order from the image side, a first lens unit including a positive meniscus lens with a convex surface facing the image side, at least two negative lenses, and at least two positive lenses, and having negative power as a whole; a second lens unit including a negative lens and a positive lens so that the radius of curvature of the surface of the negative lens, adjacent to the positive lens, is smaller than that of the opposite surface thereof; a third lens unit including biconvex positive lenses and biconcave negative lenses which have different media, so that two of the biconvex positive lenses are arranged on the object side and the image side, and having positive power as a whole; and a fourth lens unit including a negative meniscus lens and at least one positive meniscus lens, and having positive power as a whole. In this case, the objective satisfies the following condition:

$$0 < | R_{\min} / R_{\max} | < 0.5 \quad (1)$$

where R_{\min} is the radius of curvature of the surface of the negative lens, adjacent to the positive lens, in the second lens unit and R_{\max} is the radius of curvature of the opposite surface thereof.

According to the present invention, the objective preferably satisfies the following condition:

$$1 < | FL2 / FL3 | \quad (2)$$

where $FL2$ is the focal length (mm) of the second lens unit and $FL3$ is the focal length (mm) of the third lens unit.

According to the present invention, the objective preferably satisfies the fol-

lowing condition:

$$-1.5 < FL1 / FL234 < -1 \quad (3)$$

where FL1 is the focal length (mm) of the first lens unit and FL234 is a synthesized focal length (mm) of the second to fourth lens units.

5 According to the present invention, each of the first, third and fourth lens units preferably has air spacing between the positive lens and the negative lens of different media and the objective satisfies the following conditions:

$$d / L < 0.025 \quad (4)$$

$$0.58 < R_p / R_n < 1.73 \quad (5)$$

10 where L is a parfocal distance (mm) of the objective, d is the air spacing (mm), R_p is the radius of curvature of a surface with positive power, of the positive and negative lenses facing each other with air spacing between them, and R_n is the radius of curvature of a surface with negative power thereof. Also, the distance L in this condition is defined as the overall length of the objective, but when the parfocal distance of the objective is nearly equal to the overall length of the objective, the parfocal distance of the objective may be used as the distance L. Here, the overall length of the objective refers to a distance from the first lens surface to the last lens surface.

15 According to the present invention, glass materials used for the objective are preferably quartz and fluorite.

20 According to the present invention, at least one pair of lenses in which the negative lens and the positive lens of the third lens unit, different in medium, are arranged with air spacing between them are preferably such that the negative lens and the positive lens are constructed of quartz and fluorite, respectively.

25 According to the present invention, the objective preferably satisfies the following condition:

$$R_i < R_o \quad (6)$$

where R_i is the radius of curvature of the image-side surface of at least one negative lens in the first lens unit and R_o is the radius of curvature of the object-side surface

thereof.

According to the present invention, the objective preferably satisfies the following condition:

$$| \text{DUVfp} - \text{IRfp} | \leq 12 \mu\text{m} \quad (7)$$

where DUVfp is an imaging position on the object side in a deep ultraviolet region and IRfp is an imaging position on the object side of the wavelength in an infrared region.

These and other features and advantages of the present invention will become apparent from the following detailed description of the preferred embodiments when taken in conjunction with the accompanying drawings.

BRIEF DESCRIPTION OF THE DRAWINGS

Fig. 1 is a view showing a lens arrangement of a first embodiment in the present invention;

Fig. 2 is aberration diagrams of the first embodiment;

Fig. 3 is a view showing a lens arrangement of a second embodiment in the present invention;

Fig. 4 is aberration diagrams of the second embodiment;

Fig. 5 is a view showing a lens arrangement of a third embodiment in the present invention;

Fig. 6 is aberration diagrams of the third embodiment;

Fig. 7 is a view showing a lens arrangement of a fourth embodiment in the present invention;

Fig. 8 is aberration diagrams of the fourth embodiment;

Fig. 9 is a view showing a lens arrangement of a fifth embodiment in the present invention;

Fig. 10 is aberration diagrams of the fifth embodiment;

Fig. 11 is a view showing a lens arrangement of a sixth embodiment in the present invention;

Fig. 12 is aberration diagrams of the sixth embodiment; and

Fig. 13 is a view schematically showing an ordinary microscope provided with an AF device.

DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENTS

5 Before undertaking the description of the embodiments, the function and effect of the present invention will be explained below.

The objective of the present invention is constructed with single lenses, without cementing lenses of different media with adhesives. According to the present invention, chromatic aberration can be corrected, and the problem encountered in the use of the adhesives can be clarified. Further, it is possible to obtain the resolution corresponding to the wavelength of approximately 250 nm and a high numerical aperture. Still further, active AF using infrared light becomes possible and thereby it is possible to provide a deep-ultraviolet microscope which has good operativeness and does not undergo the influence of a manufacturing error.

15 The first lens unit of the present invention includes, in order from the image side, a positive meniscus lens with a convex surface facing the image side, at least two negative lenses, and at least two positive lenses, having negative power as a whole. A lens with strong negative power is placed in the first lens unit to perform the function that emerging rays on the image side are rendered parallel and at the same time, to correct curvature of field and coma such as off-axis aberrations. Since a simple placement of only a lens with negative power fails to hold the balance between aberrations, the positive meniscus lens with the convex surface facing the image side and the biconcave negative lens with strong negative power are arranged and thereby a Gauss lens system is provided so that curvature of field and chromatic aberration of magnification are corrected in a good balance as a whole. At least one pair of lenses constructed by arranging the negative lens and the positive lens of different media with air spacing between them are provided to thereby correct on-axis and off-axis aberrations including chromatic aberration which cannot be completely correct-

ed by the second to fourth lens units.

The second lens unit includes a negative lens and a positive lens. The radius of curvature of the surface of the negative lens, adjacent to the positive lens in the same lens unit, is smaller than that of the opposite surface thereof. It is for this reason that the second lens unit is caused to perform the function that spherical aberration and coma, produced in the third and fourth lens units, are neutralized by spherical aberration and coma, produced in a reverse direction. In particular, when the radius of curvature of the surface of the negative lens, adjacent to the positive lens, is reduced, spherical aberration is easily produced in the reverse direction with respect to the third and fourth lens units, and therefore, the function described above can be performed. Condition (1) prescribes correction for such aberrations. Beyond the upper limit of 0.5, the effect of correction for aberration is lessened and spherical aberration produced in the third or fourth lens unit cannot be completely corrected.

The third lens unit includes biconvex positive lenses and biconcave negative lenses which have different media so that two of the biconvex positive lenses are arranged on the object side and the image side, having positive power as a whole. Light emerging from the surface of a specimen passes through the fourth lens unit and is incident on the third lens unit by virtue of the spread of marginal rays caused at this time. In this case, however, if the third lens unit has the negative power, the rays will be further spread and a ray height (the width of the marginal ray in the Y direction from the optical axis) will be significantly increased. This means that the problem arises that the outside diameter of the lens is increased to raise the manufacturing cost and performance is liable to deteriorate because of the manufacturing error of the lens. In the present invention, therefore, the third lens unit has the positive power as a whole and the biconvex lenses are arranged on both the object and image sides, thereby reducing the height at which the marginal rays emerge from the fourth lens unit. That the ray height can be reduced is that a small outside diameter of the lens is satisfactory, and thus performance can be maintained with respect to the

manufacturing error and a change in lens shape. In addition, the negative lens and the positive lens of different media are arranged, and thereby it becomes possible to correct chromatic aberration in a DUV wavelength region of $248\text{ nm} \pm \text{a few nm}$ and on-axis chromatic aberration in an NIR (near-infrared) region used in active AF.

5 The fourth lens unit includes a negative meniscus lens and at least one positive meniscus lens and has positive power as a whole. The placement of the negative meniscus lens brings about the effect of correcting spherical aberration produced in the positive lens of the fourth lens unit. The fourth lens unit, as mentioned above, includes at least one positive meniscus lens and has the positive power as a whole,
10 and thereby monochromatic aberration can be favorably corrected in the main. In the objective with a numerical aperture of 0.7 or more, notably, of the order of 0.9, unless an angle made by a ray emerging from the object is made small, even the monochromatic aberration ceases to be correctable. However, when at least one positive meniscus lens is used and the angle of the ray is gradually reduced, the correction becomes possible.
15

Condition (2) determines the ratio between the focal lengths of the second and third lens units. Below the lower limit of 1, the focal length of the third lens unit becomes greater than that of the second lens unit. In this case, the ray height in the third lens unit is increased and the outside diameter of the lens becomes large. As a
20 result, the coefficient of correction for aberration of the third lens unit is increased, and the problem arises that the third lens unit is liable to undergo the influence of the manufacturing error.

Condition (3) determines the ratio between the focal length of the first lens unit and the synthesized focal length of the second to fourth lens units. Below the lower
25 limit of -15, the focal length of the first lens unit contributing to correction for off-axis aberration is extremely increased, namely the negative power is extremely weakened, and hence correction for coma or curvature of field becomes difficult. Beyond the upper limit of -1, the focal length of the first lens unit becomes too small,

namely the negative power becomes too strong, and thus the synthesized focal length of the second to fourth lens units is extremely increased, with the result that the positive power is lessened. Consequently, the ray height in the second to fourth lens units is increased, and the amount of production of aberration in each lens unit becomes appreciable.

The first, third, and fourth lens units are constructed with the negative lenses and the positive lenses which have different media. The objective of the present invention is based on the premise that its performance is exhibited at wavelengths of 248 nm \pm a few nm so that the first lens unit is capable of correcting chromatic aberration of magnification and the third and fourth lens units are capable of correcting on-axis chromatic aberration.

Condition (4) determines the arrangement of lenses in close proximity. Beyond the upper limit of 0.025 of Condition (4), the air spacing between the lenses becomes too wide to favorably correct chromatic aberration. Condition (5) prescribed that the radii of curvature of opposite surfaces of a pair of lenses are made almost identical. When the objective satisfies Condition (5), aberrations including chromatic aberration can be favorably corrected. Outside the limit of this condition, correction for chromatic aberration becomes particularly difficult. That is, Conditions (4) and (5) are such that even though the adhesives are not used, the lenses are caused to falsely assume the same role as in cemented lenses, and spherical aberration and chromatic aberration are corrected.

In the objective, glass materials used for individual lenses are to be quartz and fluorite. Whereby, even though media with deliquescence and birefringence are not used, an objective for a deep ultraviolet region of wavelength about 250 nm, which is good in workability and durability and high in transmittance, can be obtained.

In the objective, the negative lens and the positive lens of different media in each of the first, third, and fourth lens units are arranged with air spacing between them. Of at least one pair of lenses constructed in this way, the negative lens is

constructed of quartz and the positive lens of fluorite. Whereby, chromatic aberration of magnification in the first lens unit and aberrations including on-axis chromatic aberration in the third and fourth lens units can be more favorably corrected in the main.

5 In the objective, when an attempt is made to satisfy Condition (6) with respect to at least one negative lens in the first lens unit, a ray incident on the convex lens and the concave lens can be favorably bent.

Condition (7) determines the amount of shift of the imaging position between the deep ultraviolet region ($248 \text{ nm} \pm 5 \text{ nm}$) and the near-infrared region (wavelengths chiefly used for AF in a semiconductor laser are single wavelengths of 670-10
900 nm) on the object side. Rays emanating from the object are incident on the objective with a certain numerical aperture and become parallel light in the objective, and this light is imaged by an imaging lens. Generally, in the case of AF for microscopes, as shown in Fig. 13, a dichroic mirror DM reflecting only near-infrared light is placed at an angle of 45° with the optical axis, between the objective and the15
imaging lens. Visible light emerging from the objective passes through the dichroic mirror DM and is imaged by the observation-side imaging lens. Near-infrared light is reflected by the dichroic mirror DM and is imaged by an AF imaging lens. When the imaging position on the observation side coincides with that on the AF side, the20
imaging position on the object side is the same and therefore the AF by the near-infrared light becomes possible. Actually, however, some extent of on-axis chromatic aberration exists in the objective. In this case, the imaging position on the observation side cannot be shifted, but in order to shift the imaging position on the AF side to a preset imaging position, provision is made so that the AF imaging lens25
can be moved along the optical axis to some extent. For example, when an objective with a focal length of 1.8 mm and an imaging lens with a focal length of 180 mm are used, a 100 \times objective is obtained. Basically, the focal length of the AF imaging lens is often set to 1/2-1/4 of the focal length of the observation-side imaging lens.

The reason for this is that, with the same focal length as in the observation-side imaging lens, the amount of shift of the AF imaging lens is considerably increased.

For example, when it is assumed that a 100× objective with a focal length of 1.8 mm and an AF imaging lens with a focal length of 180 mm are used and the shift of the imaging position between visible light and near-infrared light on the object side is $\pm 5 \mu\text{m}$, the amount of shift on the AF side is given from the longitudinal magnification as

$$\pm 0.005 (\text{mm}) \times 100(\times) \times 100(\times) = \pm 50 \text{ mm}$$

With this value, it is impossible to obtain the amount of shift mentioned above because of the problems of space and a lens driving motor. Thus, when the focal length of the AF imaging lens is set to 1/2-1/4 of the focal length of the observation-side imaging lens, for example, when the focal length is 90 mm which is 1/2 thereof, the shift of the imaging position on the AF side is reduced to 1/4 as follows:

$$\pm 0.005 (\text{mm}) \times 50(\times) \times 50(\times) = \pm 12.5 \text{ mm}$$

In an ordinary objective in which the visible ray is chiefly used, the difference of wavelength is relatively small and the shift of the imaging position between visible light and near-infrared light on the object side is slight. The AF imaging lens thus requires a less amount of movement. However, since the objective for the deep ultraviolet region of the present invention is used on the basis of a wavelength of approximately 250 nm, the difference with the wavelength of near-infrared light is more than twice. Condition (7) solves this problem. Beyond the upper limit of Condition (7), the amount of movement of the AF imaging lens is extremely increased and the shift cannot be completely corrected by the AF imaging lens.

The embodiments of the present invention will be described below with reference to Figs. 1-12. In each of the embodiments of the present invention, the focal length of the objective is 1.8 mm and the range of correction wavelengths in the deep ultraviolet region is $248 \text{ nm} \pm 5 \text{ nm}$, and when the objective is combined with the imaging lens with a focal length of 180 mm, a field number of 5 mm and a magnifi-

cation of 100× are obtained. Since chromatic aberration is corrected in the limit of the wavelength region of $248 \text{ nm} \pm 5 \text{ nm}$, it is possible to use a combination with a KrF excimer laser which is not in a narrow region. Moreover, since the adhesive is not used, the objective exhibits sufficient resistance to a high-energy laser. Also, when the objective is combined with a band-pass filter with a half-width of about 7 nm, it is possible to illuminate and observe a specimen with a mercury lamp as the pre-stage of laser irradiation. By suppressing the shift of the imaging position on the object side of the deep ultraviolet region and the infrared region, AF is possible.

In each of the embodiments, aberrations shown in the aberration diagram are relative to the surface of the object in reverse tracing of the single body of the objective and their dimensions are in millimeters and percents. For spherical aberration, a dotted line denotes 248 nm, a chain line denotes 243 nm, and a solid line denotes 253 nm.

First embodiment

The lens arrangement of the first embodiment is shown in Fig. 1 and aberration characteristics are shown in Fig. 2. As will be obvious from Fig. 1, a first lens unit G1 of the first embodiment includes, in order from the image side, a positive meniscus lens L1 with a convex surface facing the image side, a negative lens L2, a positive lens L3, a negative lens L4, and a positive lens L5. Two pairs of lenses P1 and P2 are configured with three adjacent lenses L3-L5 to constitute a false cemented triplet, and the first lens unit G1 has negative power as a whole.

A second lens unit G2 includes a negative meniscus lens L6 with a concave surface facing the object side and a biconvex positive lens L7, and the radius of curvature of the surface of the negative lens L6, adjacent to the positive lens L7 in the same lens unit, is selected to be smaller than that of the opposite surface thereof.

A third lens unit G3 includes four biconvex positive lenses L8, L10, L12, and L14 and three biconcave negative lenses L9, L11, and L13 in which each of the biconvex positive lenses and each of the biconcave negative lenses have different me-

dia and are alternately arranged, so that the biconvex positive lenses L8 and L14 are arranged on the image side and the object side, respectively. In addition, six pairs of lenses P3, P4, P5, P6, P7, and P8 are configured with these seven adjacent lenses L8-L14 to constitute false cemented triplets, and the third lens unit G3 has positive power as a whole.

A fourth lens unit G4 includes a negative meniscus lens L15 with a concave surface facing the object side, a biconvex positive lens L16, and positive meniscus lenses L17 and L18, each with a convex surface facing the image side. The lenses L15 and L16 are configured as a pair of lenses P9 to constitute a false cemented doublet, and the fourth lens unit G4 has positive power as a whole.

As will be evident from Data 1 to be described below, the first embodiment satisfies Conditions (1), (2), (3), and (6), the pairs of lenses P1-P6 satisfy Conditions (4) and (5), and the imaging position of wavefront aberration on the object side in the deep ultraviolet region and the infrared region satisfies Condition (7).

Data 1

Parfocal distance = 45 mm

Range of correction for aberration in deep ultraviolet region = $248 \text{ nm} \pm 5 \text{ nm}$

NA = 0.9

WD = 0.2

Surface number	RDY	THI	Medium	Condition (4)	Condition (5)
1	INFINITY	-4			
2	2.48717	2.473969	Quartz	L1	
3	2.70108	1			
4	-2.27772	1.490233	Quartz	L2	
5	2.67967	3.214262			
6	-15.64714	3.982066	Fluorite	L3	
7	-3.66338	0.434784		P1	0.0097 1.127
8	-3.25138	1.341504	Quartz	L4	

	9	228.14528	0.232865		P2	0.0052	0.633
	10	144.4742	2.659426	Fluorite	L5		
	11	-6.35714	0.1				
	12	56.51823	1	Quartz	L6		
5	13	9.57308	0.703382				
	14	18.84184	2.359018	Fluorite	L7		
	15	-15.54698	0.1				
	16	11.87056	3.506388	Fluorite	L8		
	17	-11.87056	0.131926		P3	0.0029	0.957
10	18	-12.39959	1	Quartz	L9		
	19	9.49874	0.1		P4	0.0022	0.775
	20	7.36111	4.249929	Fluorite	L10		
	21	-10.45746	0.47826		P5	0.0106	1.291
	22	-8.10095	1	Quartz	L11		
15	23	8.10095	0.1		P6	0.0022	0.976
	24	7.90936	3.821471	Fluorite	L12		
	25	-7.90936	0.2		P7	0.0044	1.013
	26	-7.80576	0.96	Quartz	L13		
	27	7.80576	0.311743		P8	0.0069	1.140
20	28	8.89943	3.449933	Fluorite	L14		
	29	-7.92049	0.1				
	30	9.15314	1	Quartz	L15		
	31	3.68027	0.64784		P9	0.0144	1.286
	32	4.7319	2.751027	Fluorite	L16		
25	33	-15.69583	0.1				
	34	3.66954	1.798802	Fluorite	L17		
	35	7.20788	0.1				
	36	1.8327	1.853224	Quartz	L18		

37 15.44227 0.247948

FL1 = -14.122

FL2 = 74.671

FL3 = 18.602

5 FL234 = 11.767

Rmin = 9.57308

Rmax = 18.84184

10

wavelength used for AF	Imaging shift at the best position of wavefront aberration on the object side between 248 nm and each wavelength used for AF
670 nm	+4.60 μm
785 nm	+0.19 μm
900 nm	-5.64 μm

Second embodiment

15

The lens arrangement of the second embodiment is shown in Fig. 3 and aberration characteristics are shown in Fig. 4. As will be obvious from Fig. 3, the first lens unit G1 of the second embodiment includes, in order from the image side, the positive meniscus lens L1 with a convex surface facing the image side, the negative lens L2, the positive lens L3, the negative lens L4, and the positive lens L5. Two pairs of lenses P1 and P2 are configured with three adjacent lenses L3-L5 to constitute a false cemented triplet, and the first lens unit G1 has negative power as a whole.

20

The second lens unit G2 includes the biconcave negative lens L6 and the biconvex positive lens L7, and the radius of curvature of the surface of the negative lens L6, adjacent to the positive lens L7 in the same lens unit, is selected to be smaller than that of the opposite surface thereof.

25

The third lens unit G3 includes four biconvex positive lenses L8, L10, L12, and L14 and three biconcave negative lenses L9, L11, and L13 in which each of the biconvex positive lenses and each of the biconcave negative lenses have different media and are alternately arranged, so that the biconvex positive lenses L8 and L14 are

arranged on the image side and the object side, respectively. In addition, the pair of lenses P3 are configured with two adjacent lenses L8 and L9 to constitute a false cemented doublet, and four pairs of lenses P4, P5, P6, and P7 are configured with five lenses L10-L14 to constitute false cemented triplets. The third lens unit G3 has positive power as a whole.

The fourth lens unit G4 includes the negative meniscus lens L15 with a concave surface facing the object side, the biconvex positive lens L16, and the positive meniscus lenses L17 and L18, each with a convex surface facing the image side. The pair of lenses P8 are configured with two adjacent lenses L15 and L16 to constitute a false cemented doublet, and the fourth lens unit G4 has positive power as a whole.

As will be evident from Data 2 to be described below, the second embodiment satisfies Conditions (1), (2), (3), and (6), the pairs of lenses P1-P8 satisfy Conditions (4) and (5), and the imaging position of wavefront aberration on the object side in the deep ultraviolet region and the infrared region satisfies Condition (7).

Data 2

Parfocal distance = 45 mm

Range of correction for aberration in deep ultraviolet region = 248 nm \pm 5 nm

NA = 0.9

WD = 0.2

Surface number	RDY	THI	Medium	Condition (4)	Condition (5)
1	INFINITY	-4			
2	2.7384	3.051628	Quartz	L1	
3	2.53121	1			
4	-2.1847	1.047705	Quartz	L2	
5	2.86499	4.886075			
6	56.70556	2.334353	Fluorite	L3	
7	-3.99727	0.495399		P1	0.0110 1.186
8	-3.37138	1	Quartz	L4	

	9	-48.98121	0.280628		P2	0.0062	0.835
	10	-40.90839	2.734155	Fluorite	L5		
	11	-5.36137	0.1				
	12	-112.9024	1	Quartz	L6		
5	13	8.7118	0.977655				
	14	44.19142	2.184896	Fluorite	L7		
	15	-12.32926	0.1				
	16	15.55116	3.305937	Fluorite	L8		
	17	-9.72897	0.320949		P3	0.0071	1.116
10	18	-8.71964	1	Quartz	L9		
	19	24.0111	0.1				
	20	8.64398	4.054088	Fluorite	L10		
	21	-10.49908	0.297857		P4	0.0066	1.105
	22	-9.50178	1	Quartz	L11		
15	23	7.11952	0.209897		P5	0.0047	1.027
	24	7.31004	3.925088	Fluorite	L12		
	25	-8.00503	0.200654		P6	0.0045	1.040
	26	-7.70025	0.96	Quartz	L13		
	27	7.18457	0.376765		P7	0.0084	1.180
20	28	8.47627	3.566291	Fluorite	L14		
	29	-7.54149	0.1				
	30	8.54606	1	Quartz	L15		
	31	3.58988	0.685352		P8	0.0152	1.320
	32	4.73777	2.692071	Fluorite	L16		
25	33	-15.80256	0.1				
	34	3.77816	1.763192	Fluorite	L17		
	35	8.04338	0.1				
	36	1.86328	1.807165	Quartz	L18		

37 54.41499 0.242201

FL1 = -50

FL2 = -118.549

FL3 = 17.046

5 FL234 = -9.710

Rmin = 8.7118

Rmax = 44.19142

10

wavelength used for AF	Imaging shift at the best position of wavefront aberration on the object side between 248 nm and each wavelength used for AF
670 nm	+4.04 μm
785 nm	+0.35 μm
900 nm	-6.14 μm

Third embodiment

15 The lens arrangement of the third embodiment is shown in Fig. 5 and aberration characteristics are shown in Fig. 6. As will be obvious from Fig. 5, the first lens unit G1 of the third embodiment includes, in order from the image side, the positive meniscus lens L1 with a convex surface facing the image side, the negative lens L2, the positive lens L3, the negative lens L4, and the positive lens L5. The pair of
20 lenses P1 are configured with two adjacent lenses L3 and L4 to constitute a false cemented doublet, and the first lens unit G1 has negative power as a whole.

 The second lens unit G2 includes the negative meniscus lens L6 with a concave surface facing the object side, the biconvex positive lens L7, the positive meniscus lens L8 with a convex surface facing the object side, and the biconcave negative lens
25 L9, and the radius of curvature of the surface of each of the first negative lens L6 and the second negative lens L9, adjacent to the positive lens in the same lens unit, is selected to be smaller than that of the opposite surface thereof.

 The third lens unit G3 includes three biconvex positive lenses L10, L12, and L14 and two biconcave negative lenses L11 and L13 in which each of the biconvex

positive lenses and each of the biconcave negative lenses have different media and are alternately arranged, so that the biconvex positive lenses L10 and L14 are arranged on the image side and the object side, respectively. In addition, four pairs of lenses P2, P3, P4, and P5 are configured with these five adjacent lenses L10-L14 to constitute false cemented triplets, and the third lens unit G3 has positive power as a whole.

The fourth lens unit G4 includes the negative meniscus lens L15 with a concave surface facing the object side, the biconvex positive lens L16, and the positive meniscus lenses L17 and L18, each with a convex surface facing the image side. The pair of lenses P6 are configured with the lenses L15 and L16 to constitute a false cemented doublet, and the fourth lens unit G4 has positive power as a whole.

As will be evident from Data 3 to be described below, the third embodiment satisfies Conditions (1), (2), (3), and (6), the pairs of lenses P1-P6 satisfy Conditions (4) and (5), and the imaging position of wavefront aberration on the object side in the deep ultraviolet region and the infrared region satisfies Condition (7).

Data 3

Parfocal distance = 45 mm

Range of correction for aberration in deep ultraviolet region = 248 nm ± 5 nm

NA = 0.9

WD = 0.2

Surface number	RDY	THI	Medium		Condition (4)	Condition (5)
1	INFINITY	-4				
2	2.73864	2.905691	Quartz	L1		
3	2.58448	1				
4	-2.33399	1	Quartz	L2		
5	2.74587	4.60997				
6	111.16539	2.171309	Fluorite	L3		
7	-4.40895	0.364855			P1	0.0081 1.102

5	8	-3.99917	1	Quartz L4			
	9	12.05086	0.651716				
	10	88.43996	3.353388	Fluorite L5			
	11	-5.03227	0.1				
	12	32.23164	1	Quartz L6			
10	13	8.1197	0.591245				
	14	12.03154	2.747198	Fluorite L7			
	15	-11.83617	0.1				
	16	-154.9676	2.377842	Fluorite L8			
	17	-10.73268	0.649676				
15	18	-7.22798	1	Quartz L9			
	19	78.57585	0.1				
	20	8.92775	3.974339	Fluorite L10			
	21	-9.61008	0.311032		P2	0.0069	1.114
	22	-8.62521	1	Quartz L11			
20	23	7.11859	0.200013		P3	0.0044	1.021
	24	7.27162	4.006314	Fluorite L12			
	25	-7.45452	0.2		P4	0.0044	1.039
	26	-7.17335	0.96	Quartz L13			
	27	7.36105	0.347197		P5	0.0077	1.169
25	28	8.60817	3.72229	Fluorite L14			
	29	-7.10645	0.1				
	30	9.71336	1	Quartz L15			
	31	3.61075	0.686382		P6	0.0153	1.318
	32	4.75808	2.775991	Fluorite L16			
	33	-12.71179	0.1				
	34	3.89726	1.801922	Fluorite L17			
	35	11.53447	0.1				

36 1.99349 1.750459 Quartz L18

37 104.07304 0.241172

FL1 = -33.502

FL2 = 443.557

5 FL3 = 15.410

FL234 = 6.788

10

wavelength used for AF	Imaging shift at the best position of wavefront aberration on the object side between 248 nm and each wavelength used for AF
670 nm	-0.61 μm
785 nm	+3.93 μm
900 nm	-6.58 μm

Rmin1 = 8.1197

Rmax1 = 12.03154

15

Rmin2 = -7.22798

Rmax2 = -10.73268

Fourth embodiment

20

The lens arrangement of the fourth embodiment is shown in Fig. 7 and aberration characteristics are shown in Fig. 8. As will be obvious from Fig. 7, the first lens unit G1 of the fourth embodiment includes, in order from the image side, the positive meniscus lens L1 with a convex surface facing the image side, the negative lens L2, the positive lens L3, the negative lens L4, and the positive lens L5. The pair of lenses P1 are configured with two adjacent lenses L3 and L4 to constitute a false cemented doublet, and the first lens unit G1 has negative power as a whole.

25

The second lens unit G2 includes the negative meniscus lens L6 with a concave surface facing the object side and the biconvex positive lens L7, and the radius of curvature of the surface of the negative lens L6, adjacent to the positive lens L7 in the same lens unit, is selected to be smaller than that of the opposite surface thereof.

The third lens unit G3 includes four biconvex positive lenses L8, L10, L12, and

L14 and three biconcave negative lenses L9, L11, and L13, and has positive power as a whole. Each of the biconvex positive lenses and each of the biconcave negative lenses have different media and are alternately arranged. The biconvex positive lenses L8 and L14 are arranged on the image side and the object side, respectively. In addition, the pair of lenses P2 are configured with two adjacent lenses L8 and L9 to constitute a false cemented doublet. Four pairs of lenses P3, P4, P5, and P6 are configured with five lenses L10-L14 to constitute false cemented triplets.

The fourth lens unit G4 includes the negative meniscus lens L15 with a concave surface facing the object side, the biconvex positive lens L16, the positive meniscus lenses L17 with a convex surface facing the image side, and the positive lens L18. The pair of lenses P7 are configured with the lenses L15 and L16 to constitute a false cemented doublet, and the fourth lens unit G4 has positive power as a whole.

As will be evident from Data 4 to be described below, the fourth embodiment satisfies Conditions (1), (2), (3), and (6), the pairs of lenses P1-P7 satisfy Conditions (4) and (5), and the imaging position of wavefront aberration on the object side in the deep ultraviolet region and the infrared region satisfies Condition (7).

Data 4

Parfocal distance = 45 mm

Range of correction for aberration in deep ultraviolet region = $248 \text{ nm} \pm 5 \text{ nm}$

NA = 0.9

WD = 0.2

Surface number	RDY	THI	Medium	Condition (4)	Condition (5)
1	INFINITY	-4			
2	2.81397	3.09206	Quartz L1		
3	2.76385	1			
4	-2.31856	1.492274	Quartz L2		
5	2.7277	4.262613			
6	-75.21087	2.180498	Fluorite L3		

	7	-3.71239	0.42553		P1	0.0095	1.143
	8	-3.24702	1	Quartz	L4		
	9	23.08615	0.509333				
	10	-136.3743	3.049067	Fluorite	L5		
5	11	-4.95289	0.1				
	12	59.70625	1	Quartz	L6		
	13	8.70576	0.810219				
	14	21.37872	2.373098	Fluorite	L7		
	15	-12.69628	0.1				
10	16	23.97133	3.159241	Fluorite	L8		
	17	-8.70394	0.314847		P2	0.0070	1.107
	18	-7.85928	1	Quartz	L9		
	19	24.51209	0.1				
	20	8.67237	3.972724	Fluorite	L10		
15	21	-10.43664	0.333853		P3	0.0074	1.142
	22	-9.14266	1	Quartz	L11		
	23	7.13901	0.198711		P4	0.0044	1.020
	24	7.2852	3.942702	Fluorite	L12		
	25	-7.84279	0.193868		P5	0.0043	1.033
20	26	-7.59235	0.96	Quartz	L13		
	27	7.6216	0.3644		P6	0.0081	1.186
	28	9.04242	3.54172	Fluorite	L14		
	29	-7.48584	0.1				
	30	8.84686	1	Quartz	L15		
25	31	3.69613	0.705709		P7	0.0157	1.349
	32	4.98561	2.714623	Fluorite	L16		
	33	-13.30046	0.1				
	34	3.89708	1.765252	Fluorite	L17		

35 8.91324 0.1
 36 1.90219 1.794209 Quartz L18
 37 34.95039 0.24345

FL1 = -23.968

FL2 = 77.984

FL3 = 18.192

FL234 = 7.088

Rmin = 8.70576

Rmax = 21.37872

wavelength used for AF	Imaging shift at the best position of wavefront aberration on the object side between 248 nm and each wavelength used for AF
670 nm	+3.90 μm
785 nm	-0.55 μm
900 nm	-6.24 μm

Fifth embodiment

The lens arrangement of the fifth embodiment is shown in Fig. 9 and aberration characteristics are shown in Fig. 10. As will be obvious from Fig. 9, the first lens unit G1 of the fifth embodiment includes, in order from the image side, the positive meniscus lens L1 with a convex surface facing the image side, the negative lens L2, the positive lens L3, the negative lens L4, and the positive lens L5. Two pairs of lenses P1 and P2 are configured with three adjacent lenses L3-L5 to constitute a false cemented triplet, and the first lens unit G1 has negative power as a whole.

The second lens unit G2 includes the negative meniscus lens L6 with a concave surface facing the object side and the biconvex positive lens L7, and the radius of curvature of the surface of the negative lens L6, adjacent to the positive lens L7 in the same lens unit, is selected to be smaller than that of the opposite surface thereof.

The third lens unit G3 includes four biconvex positive lenses L8, L10, L12, and L14 and three biconcave negative lenses L9, L11, and L13 in which each of the bi-

convex positive lenses and each of the biconcave negative lenses have different media and are alternately arranged, so that the biconvex positive lenses L8 and L14 are arranged on the image side and the object side, respectively. In addition, the pair of lenses P3 are configured with two adjacent lenses L8 and L9 to constitute a false cemented doublet, and four pairs of lenses P4, P5, P6, and P7 are configured with five lenses L10-L14 to constitute false cemented triplets. The third lens unit G3 has positive power as a whole.

The fourth lens unit G4 includes the negative meniscus lens L15 with a concave surface facing the object side, the biconvex positive lens L16, and the positive meniscus lenses L17 and L18, each with a convex surface facing the image side. The pair of lenses P8 are configured with the lenses L15 and L16 to constitute a false cemented doublet, and the fourth lens unit G4 has positive power as a whole.

As will be evident from Data 5 to be described below, the fifth embodiment satisfies Conditions (1), (2), (3), and (6), the pairs of lenses P1-P8 satisfy Conditions (4) and (5), and the imaging position of wavefront aberration on the object side in the deep ultraviolet region and the infrared region satisfies Condition (7).

Data 5

Parfocal distance = 45 mm
 Range of correction for aberration in deep ultraviolet region = 248 nm \pm 5 nm
 NA = 0.9
 WD = 0.2

Surface number	RDY	THI	Medium	Condition (4)	Condition (5)
1	INFINITY	-4			
2	2.71159	2.905407	Quartz	L1	
3	2.78435	1			
4	-2.31651	1.412157	Quartz	L2	
5	2.7253	4.418894			
6	-18.87975	2.487348	Fluorite	L3	

	7	-3.62417	0.433359		P1	0.0096	1.135
	8	-3.19218	1	Quartz	L4		
	9	-61.99509	0.25793		P2	0.0057	0.981
	10	-60.81569	2.678607	Fluorite	L5		
5	11	-5.47827	0.1				
	12	220.57961	1	Quartz	L6		
	13	9.08685	0.879978				
	14	31.41704	2.225112	Fluorite	L7		
	15	-13.39864	0.1				
10	16	14.01766	3.54376	Fluorite	L8		
	17	-9.08325	0.214654		P3	0.0048	1.035
	18	-8.77543	1	Quartz	L9		
	19	15.73139	0.1				
	20	7.76576	4.277461	Fluorite	L10		
15	21	-10.30516	0.393835		P4	0.0088	1.201
	22	-8.57884	1	Quartz	L11		
	23	7.171	0.200263		P5	0.0045	1.021
	24	7.32009	3.935647	Fluorite	L12		
	25	-7.89289	0.200186		P6	0.0044	1.040
20	26	-7.59194	0.96	Quartz	L13		
	27	8.07009	0.313274		P7	0.0070	1.131
	28	9.12468	3.384142	Fluorite	L14		
	29	-8.12096	0.1				
	30	8.60096	1	Quartz	L15		
25	31	3.67872	0.702655		P8	0.0156	1.343
	32	4.94159	2.700085	Fluorite	L16		
	33	-14.70578	0.1				
	34	3.73742	1.791677	Fluorite	L17		

35 7.85852 0.1
 36 1.84237 1.836756 Quartz L18
 37 17.62537 0.246814

FL1 = -20.6369

FL2 = 1845.95

FL3 = 17.640

FL234 = 7.377

Rmin = 9.08685

Rmax = 31.41704

wavelength used for AF	Imaging shift at the best position of wavefront aberration on the object side between 248 nm and each wavelength used for AF
670 nm	+4.22 μm
785 nm	-0.20 μm
900 nm	-6.03 μm

Sixth embodiment

The lens arrangement of the sixth embodiment is shown in Fig. 11 and aberration characteristics are shown in Fig. 12. As will be obvious from Fig. 11, the first lens unit G1 of the sixth embodiment includes, in order from the image side, the positive meniscus lens L1 with a convex surface facing the image side, the negative lens L2, the positive lens L3, the negative lens L4, and the positive lens L5. Two pairs of lenses P1 and P2 are configured with three adjacent lenses L3-L5 to constitute a false cemented triplet, and the first lens unit G1 has negative power as a whole.

The second lens unit G2 includes the biconvex positive lens L6 and the negative meniscus lens L7 with a concave surface facing the image side, and the radius of curvature of the surface of the negative lens L7, adjacent to the positive lens L6 in the same lens unit, is selected to be smaller than that of the opposite surface thereof.

The third lens unit G3 includes four biconvex positive lenses L8, L10, L12, and L14 and three biconcave negative lenses L9, L11, and L13 in which each of the bi-

convex positive lenses and each of the biconcave negative lenses have different media and are alternately arranged, so that the biconvex positive lenses L8 and L14 are arranged on the image side and the object side, respectively. In addition, six pairs of lenses P3, P4, P5, P6, P7, and P8 are configured with these seven adjacent lenses L8-L14 to constitute false cemented triplets, and the third lens unit G3 has positive power as a whole.

The fourth lens unit G4 includes the negative meniscus lens L15 with a concave surface facing the object side, the biconvex positive lens L16, and the positive meniscus lenses L17 and L18, each with a convex surface facing the image side. The lenses L15 and L16 are configured as the pair of lenses P9 to constitute a false cemented doublet, and the fourth lens unit G4 has positive power as a whole.

As will be evident from Data 6 to be described below, the sixth embodiment satisfies Conditions (1), (2), (3), and (6), the pairs of lenses P1-P9 satisfy Conditions (4) and (5), and the imaging position of wavefront aberration on the object side in the deep ultraviolet region and the infrared region satisfies Condition (7).

Data 6

Parfocal distance = 45 mm

Range of correction for aberration in deep ultraviolet region = 248 nm ± 5 nm

NA = 0.9

WD = 0.2

Surface number	RDY	THI	Medium	Condition (4)	Condition (5)
1	INFINITY	-4			
2	2.40698	2.481247	Quartz L1		
3	2.4729	1			
4	-2.06668	1.00205	Quartz L2		
5	2.43139	5.396129			
6	20.17433	2.407156	Fluorite L3		
7	-5.53323	0.259513		PI 0.0058	1.017

	8	-5.44118	1.24444	Quartz L4			
	9	8.91162	0.401085		P2	0.0089	1.357
	10	12.09094	3.156645	Fluorite L5			
	11	-7	0.1				
5	12	61.22577	2.241903	Fluorite L6			
	13	-12.63263	0.757738				
	14	-7.52366	1	Quartz L7			
	15	-31.66303	0.1				
	16	12.668	3.389652	Fluorite L8			
10	17	-11.03464	0.1		P3	0.0022	0.969
	18	-11.38305	1	Quartz L9			
	19	11.02999	0.1		P4	0.0022	0.682
	20	7.52787	4.19599	Fluorite L10			
	21	-10.19725	0.484353		P5	0.0108	1.293
15	22	-7.8871	1	Quartz L11			
	23	7.89473	0.1		P6	0.0022	0.951
	24	7.50757	3.837795	Fluorite L12			
	25	-8.29073	0.200736		P7	0.0045	1.036
	26	-8.00414	0.96	Quartz L13			
20	27	10.08674	0.20286		P8	0.0045	1.017
	28	10.2603	3.160175	Fluorite L14			
	29	-9.13166	0.1				
	30	8.6418	1	Quartz L15			
	31	3.72211	0.672984		P9	0.0150	1.304
25	32	4.85348	2.69256	Fluorite L16			
	33	-21.05717	0.1				
	34	3.59888	1.866016	Fluorite L17			
	35	7.37659	0.1				

36 1.77692 1.931898 Quartz L18

37 7.15061 0.257076

FL1 = -32.892

FL2 = -211.743

5 FL3 = 18.024

FL234= 6.493

Rmin = -7.52366

Rmax = -12.63263

10

wavelength used for AF	Imaging shift at the best position of wavefront aberration on the object side between 248 nm and each wavelength used for AF
670 nm	+3.31 μm
785 nm	-1.26 μm
900 nm	-7.25 μm

15

According to the present invention, as will be evident from the above description, a high-NA deep ultraviolet object can be provided in which chromatic aberration can be corrected without using any cemented lens, the resolution is greatly improved in order to accommodate a fine structure required for a high-integration semiconductor and a mass-storage optical media, focusing is performed instantaneously by making AF possible, and excellent imaging performance is maintained with respect to the manufacturing error.

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